TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TC7S02F, TC7S02FU

2-INPUT NOR GATE

The TC7S02 is a high speed C²MOS 2-INPUT NOR GATE fabricated with silicon gate C²MOS technology. It achieves high speed operation similar to equivalent LSTTL while maintaining the C²MOS low power dissipation.

The internal circuit is composed of 3 stages including buffer output, which enables high noise immunity and stable output.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

Output currents are 1/2 compared to TC74HC series

models.

FEATURES

•	High Speed	 $t_{pd} = 7ns$ $V_{CC} = 5V$	(Typ.)	at
		v((- 3 v		

• Low Power Dissipation
$$I_{CC} = 1\mu A$$
 (Max.) at

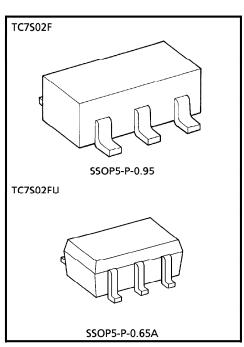
$$Ta = 25^{\circ}C$$

• Symmetrical Output Impedance ...
$$|I_{OH}| = I_{OL}$$

= 2mA (Min.)

Balanced Propagation Delays t_{pLH}≒t_{pHL}

• Wide Operating Voltage Range ... $V_{CC(opr)} = 2 \sim 6V$

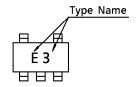


Weight SSOP5-P-0.95 : 0.016g (Typ.) SSOP5-P-0.65A : 0.006g (Typ.)

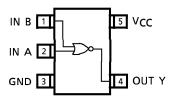
MAXIMUM RATINGS

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage Range	Vcc	-0.5~7	V
DC Input Voltage	V _{IN}	-0.5~V _{CC} +0.5	V
DC Output Voltage	VOUT	-0.5~V _{CC} + 0.5	>
Input Diode Current	ΙΚ	± 20	mΑ
Output Diode Current	loк	± 20	mA
DC Output Current	lout	± 12.5	mΑ
DC V _{CC} /Ground Current	lcc	± 25	mΑ
Power Dissipation	PD	200	mW
Storage Temperature	T _{stg}	- 65∼150	°C
Lead Temperature (10s)	ΤL	260	°C

MARKING



PIN ASSIGNMENT (TOP VIEW)



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LOGIC DIAGRAM

RECOMMENDED OPERATING CONDITIONS

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage	Vcc	2~6	V
Input Voltage	VIN	0~V _{CC}	V
Output Voltage	Vout	0~V _{CC}	V
Operating Temperature	T _{opr}	- 40~85	°C
		$0\sim1000 \ (V_{CC}=2.0V)$	
Input Rise and Fall Time	t _r , t _f	$0 \sim 500 \ (V_{CC} = 4.5V)$	ns
		$0 \sim 400 \ (V_{CC} = 6.0V)$	

DC ELECTRICAL CHARACTERISTICS

CHARACTERISTIC	SYMBOL	YMBOL TEST CONDITION			Т	Ta = 25°C			Ta = -40~85°C	
CHARACTERISTIC	STIVIBOL			Vcc	MIN.	TYP.	MAX.	MIN.	MAX.	UNIT
High Lovel				2.0	1.5	_	_	1.5	_	
High-Level	VIH		_	4.5	3.15	_	_	3.15	<u> </u>	V
Input Voltage				6.0	4.2	_	—	4.2	—	
Love Lovel				2.0	_	_	0.5	_	0.5	
Low-Level	V _{IL}		_	4.5	-	_	1.35	_	1.35	V
Input Voltage				6.0	_	_	1.8	_	1.8	
				2.0	1.9	2.0	_	1.9	_	_
112.1.11	VOH	V _{IN} = V _{IL}	$I_{OH} = -20\mu A$	4.5	4.4	4.5	—	4.4	—	
High-Level				6.0	5.9	6.0	—	5.9	—	V
Output Voltage			I _{OH} = -2mA	4.5	4.18	4.31	_	4.13	_	
			$I_{OH} = -2.6 mA$	6.0	5.80	5.80	 	5.63	<u> </u>	
				2.0	_	0.0	0.1	_	0.1	
l		., .,	$I_{OL} = 20 \mu A$	4.5	l —	0.0	0.1	_	0.1	
Low-Level	VOL	$V_{IN} = V_{IH}$		6.0	 	0.0	0.1	<u> </u>	0.1	v I
Output Voltage		or V _{IL}	I _{OL} = 2mA	4.5		0.17	0.26	_	0.33	
			$I_{OL} = 2.6 mA$	6.0	_	0.18	0.26	_	0.33	
Input Leakage	lini	\/\r\ - \/\c c \	or GND	6.0			± 0.1		± 1.0	
Current	IN	A = ACC	$V_{IN} = V_{CC}$ or GND				_ 0.1	_	1.0	,
Quiescent	laa	V V. a. or CND		6.0			1.0		10.0	μ A
Supply Current ICC VIN=VCC or GND		טווט וכ	0.0			1.0		10.0		

Output currents are 1/2 compared to TC74HC series models.

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 The information contained herein is subject to change without notice.

AC ELECTRICAL C	CHARACTERISTICS	$(C_L = 15pF,$	Input $t_r = t$	$f = 6$ ns, $V_{CC} = 5V$)
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CHARACTERISTIC	SYMBOL	TEST CONDITION	Т	Ta = 25°C		UNIT
CHARACTERISTIC	STIVIBUL	N TEST CONDITION		TYP.	MAX.	
Output Transition	tTLH	_		5	10	ns
Time	tTHL					113
Propagation Delay	t _{pLH}			7	15	nc
Time	t _{pHL}	_		_ ′	13	ns

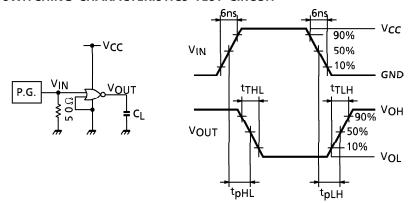
AC ELECTRICAL CHARACTERISTICS ($C_L = 50pF$, Input $t_r = t_f = 6ns$)

				т т	a = 25°	c	Ta - /	O- 0E°C	
CHARACTERISTIC	SYMBOL	TEST CONDITION		I		<u></u>	Ta = -40	10~85 C	UNIT
CHARACTERISTIC	JIWIDOL	TEST CONDITION	Vcc	MIN.	TYP.	MAX.	MIN.	MAX.	0
Output Transition	4		2.0	_	50	125	_	155	
Output Transition	t _{TLH}	_	4.5		14	25	 	31	ns
Time	^t THL		6.0	—	12	21	—	26	
Dramagation Dalay			2.0	_	48	100	_	125	
Propagation Delay	t _{pLH}	_	4.5		12	20	<u> </u>	25	ns
Time	t _{pHL}		6.0	_	9	17	_	21	
Input Capacitance	CIN	_		_	5	10	_	10	
Power Dissipation Capacitance	C _{PD}	(Note 1)		_	10	_	_	_	pF

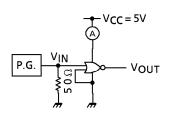
Note 1: CpD defined as the value of internal equivalent capacitance of IC which is calculated from the operating current consumption without load (refer to Test Circuit).

Average operating current can be obtained by the equation hereunder.

SWITCHING CHARACTERISTICS TEST CIRCUIT



ICC (opr) TEST CIRCUIT

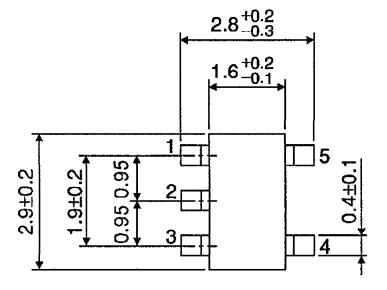


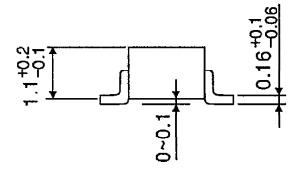
Input waveform is the same as that in case of switching characteristics test.

OUTLINE DRAWING

SSOP5-P-0.95

Unit: mm



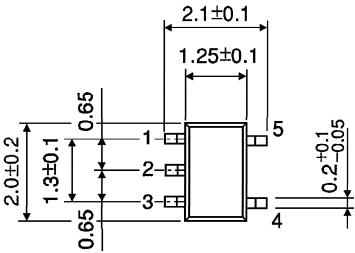


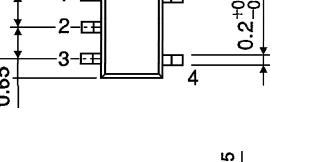
Weight: 0.016g (Typ.)

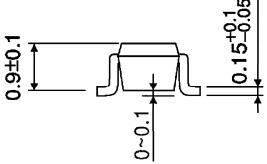
Unit: mm

OUTLINE DRAWING

SSOP5-P-0.65A







Weight: 0.006g (Typ.)